



## SOD-323 Plastic-Encapsulate Diodes

### ESDBKU3V0D3 ESD PROTECTION DIODE

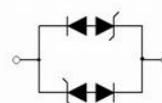
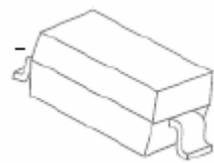
#### DESCRIPTION

The ESDBKU3V0D3 is designed to protect voltage sensitive components from ESD. Excellent clamping capability, low leakage, and fast response time provide best in class protection on designs that are exposed to ESD.

#### FEATURE

- Low Reverse Stand-off Voltage: 3.0 V
- Low Leakage Current
- Response Time is Typically < 1 ns
- ESD Rating of Class 3(<16kV) Per Human Body Model
- IEC61000-4-2 Level 4 ESD Protection
- These are Pb-Free Devices
- Low Capacitance Steering Diodes and a TVS Diode in a Single Package

SOD-323



#### APPLICATION

- Computers and peripherals
- Communications systems
- Audio and video equipment
- High speed data lines
- Parallel ports

#### MAXIMUM RATINGS (T<sub>A</sub>=25°C unless otherwise noted)

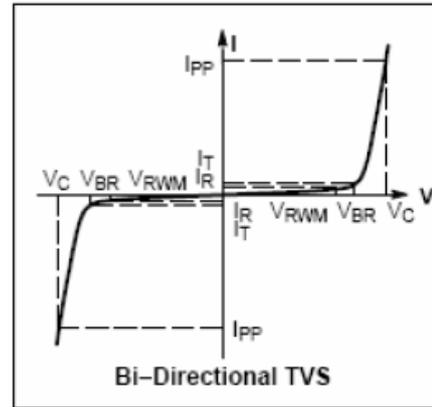
Parameter	Symbol	Limit	Unit
Electrostatic Discharge Voltage (IEC61000-4-2 ) (note1)	V <sub>ESD</sub>	±30	kV
		±30	
		16	
		0.4	
ESD Voltage(JESD22-A114-B) (note 1)			
ESD Voltage (note 1)			
Peak Pulse Power (8/20μs Waveform)	P <sub>PP</sub>	300	W
Peak Pulse Current (8/20μs Waveform)	I <sub>PP</sub>	19	A
Lead Solder Temperature – Maximum (10 Second Duration)	T <sub>L</sub>	260	°C
Junction Temperature	T <sub>J</sub>	150	°C
Storage Temperature Range	T <sub>stg</sub>	-55 ~ +150	°C

Note: 1.Device stressed with ten non-repetitive ESD pulses.

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only.Functional operation above the Recommended.Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## ELECTRICAL PARAMETER

Symbol	Parameter
$I_{PP}$	Maximum Reverse Peak Pulse Current
$V_C$	Clamping Voltage @ $I_{PP}$
$V_{RWM}$	Working Peak Reverse Voltage
$I_R$	Maximum Reverse Leakage Current @ $V_{RWM}$
$V_{BR}$	Breakdown Voltage @ $I_T$
$I_T$	Test Current



## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Device <sup>(1)</sup>	Device Marking	$V_{RWM}$ (V)	$I_R$ ( $\mu\text{A}$ ) @ $V_{RWM}$	$V_{BR}$ (V) <sup>(2)</sup> @ $I_T=1\text{mA}$		$V_{C1}$ (V) @ $I_{PP}^{(3)}=1\text{ A}$	$V_{C2}$ (V) @ $I_{PP}^{(3)}=5\text{ A}$	$V_{C_{MAX}}$ (V) @ $I_{PP(max)}^{(3)}=19\text{ A}$	C (pF) @ $V_R=0, f=1\text{MHz}$	
		Max	Max	Min	Max	Max	Max	Max	Typ	Max
<b>ESDBKU3V0D3</b>	<b>AC</b>	3	20	4	6	7	10	15.8	1.5	2

(1) Other voltages available upon request.

(2)  $V_{BR}$  is measured with a pulse test current  $I_T$  at an ambient temperature of  $25^\circ\text{C}$ .

(3) Non-repetitive current pulse 8/20 $\mu\text{s}$  exponential decay waveform according to IEC 61000-4-5.

# Typical Characteristics ESDBKU3V0D3

